

N-Ch MOSFET

### **General Description**

The WSF25N20 is the highest performance trench N-Ch MOSFET with extreme high cell density, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications .

The WSF25N20 meet the RoHS and Green Product requirement , 100% EAS guaranteed with full function reliability approved.

#### Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent Cdv/dt effect decline
- Green Device Available

## **Product Summery**

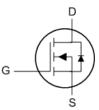
BV <sub>DSS</sub>	R <sub>DSON</sub>	I <sub>D</sub>
200V	60mΩ	25A

#### Applications

- High Frequency Point-of-Load Synchronous
  Buck Converter
- Networking DC-DC Power System
- Load Switch

## **TO-252 Pin Configuration**





Symbol	Parameter	Rating	Units
V <sub>DS</sub>	Drain-Source Voltage	200	V
V <sub>GS</sub>	Gate-Source Voltage	±20	V
I <sub>D</sub> @T <sub>C</sub> =25℃	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	25	А
I <sub>D</sub> @T <sub>C</sub> =100℃	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	16	A
I <sub>D</sub> @T <sub>A</sub> =25℃	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	3.7	A
I <sub>D</sub> @T <sub>A</sub> =70℃	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	3.0	A
I <sub>DM</sub>	Pulsed Drain Current <sup>2</sup>	75	A
EAS	Single Pulse Avalanche Energy <sup>3</sup>	35	mJ
I <sub>AS</sub>	Avalanche Current	6.5	A
P₀@T₀=25℃	Total Power Dissipation <sup>3</sup>	113	W
P₀@Tc=100℃	Total Power Dissipation <sup>3</sup>	45	W
T <sub>STG</sub>	Storage Temperature Range -55 to 150		°C
TJ	Operating Junction Temperature Range -55 to 150		°C

## **Thermal Data**

Symbol	Parameter	Тур.	Max.	Unit
R <sub>0JA</sub>	Thermal Resistance Junction-ambient <sup>1</sup>		50	°C/W
R <sub>eJC</sub>	Thermal Resistance Junction-Case <sup>1</sup>		1.1	°C/W

## **Absolute Maximum Ratings**



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### Electrical Characteristics (T<sub>J</sub>=25<sup>1</sup>C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	200			V
$\triangle BV_{DSS} / \triangle T_J$	BVDSS Temperature Coefficient	Reference to 25 $^\circ\!\mathrm{C}$ , I_D=1mA		0.098		V/℃
Б	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =10V , I <sub>D</sub> =12A		60	75	mΩ
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =6.0V , I <sub>D</sub> =10A		85	150	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage		1.0	1.5	2.5	V
$ riangle V_{GS(th)}$	V <sub>GS(th)</sub> Temperature Coefficient	$V_{GS}=V_{DS}$ , $I_D=250$ uA		-4.57		mV/°C
	Drain Source Lookage Current	V <sub>DS</sub> =160V , V <sub>GS</sub> =0V , T <sub>J</sub> =25℃			1	uA
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =160V , V <sub>GS</sub> =0V , T <sub>J</sub> =55℃			5	
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS}=\pm25V$ , $V_{DS}=0V$			±100	nA
gfs	Forward Transconductance	V <sub>DS</sub> =5V , I <sub>D</sub> =8A		20		S
Rg	Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz		2	4	Ω
Qg	Total Gate Charge (10V)	V <sub>DS</sub> =100V , V <sub>GS</sub> =10V , I <sub>D</sub> =12A		40		
Q <sub>gs</sub>	Gate-Source Charge			14		nC
Q <sub>gd</sub>	Gate-Drain Charge			10		
T <sub>d(on)</sub>	Turn-On Delay Time			16		
Tr	Rise Time	V <sub>DD</sub> =30V , V <sub>GS</sub> =10V , R <sub>G</sub> =6Ω, I <sub>D</sub> =12A, RL=30Ω		7		
T <sub>d(off)</sub>	Turn-Off Delay Time			37		ns
T <sub>f</sub>	Fall Time			15		
Ciss	Input Capacitance	V <sub>DS</sub> =30V , V <sub>GS</sub> =0V , f=1MHz		2350		
C <sub>oss</sub>	Output Capacitance			155		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			45		

#### **Guaranteed Avalanche Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
EAS	Single Pulse Avalanche Energy <sup>5</sup>	V <sub>DD</sub> =25V , L=0.5mH , I <sub>AS</sub> =6.5A	10			mJ

## **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current <sup>1,6</sup>	(-1)(-0)( Earge Current			12	А
I <sub>SM</sub>	Pulsed Source Current <sup>2,6</sup>	$V_G = V_D = 0V$ , Force Current			36	А
V <sub>SD</sub>	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V , I <sub>S</sub> =12A , T <sub>J</sub> =25℃			1.3	V
t <sub>rr</sub>	Reverse Recovery Time			75		nS
Qrr	Reverse Recovery Charge	IF=12A , dl/dt=100A/ $\mu s$ , T <sub>J</sub> =25 $^\circ C$		250		nC

Note :

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper,t<=10sec.

2.The data tested by pulsed , pulse width  $\,\leq\,$  300us , duty cycle  $\,\leq\,$  2%

3. The EAS data shows Max. rating . The test condition is  $V_{DD}$ =25V, $V_{GS}$ =10V,L=0.5mH,I<sub>AS</sub>=6.5A

4.The power dissipation is limited by  $150^{\circ}$ C junction temperature

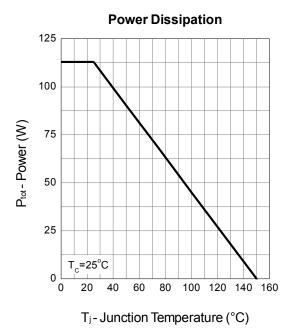
5. The Min. value is 100% EAS tested guarantee.

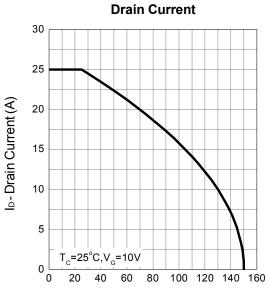
6.The data is theoretically the same as  $I_{\text{D}}$  and  $I_{\text{DM}}$  , in real applications , should be limited by total power dissipation.



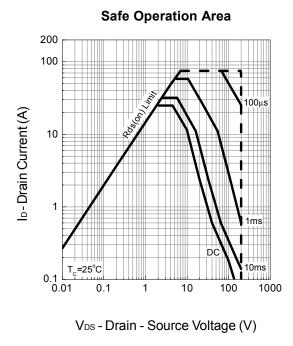
**N-Ch MOSFET** 

## **Typical Characteristics**

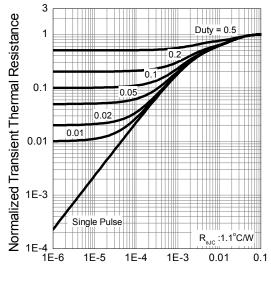




T<sub>j</sub>-Junction Temperature



Thermal Transient Impedance

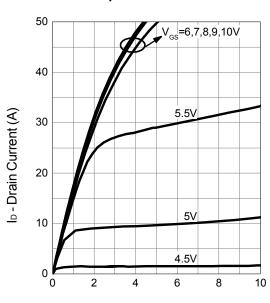


Square Wave Pulse Duration (sec)

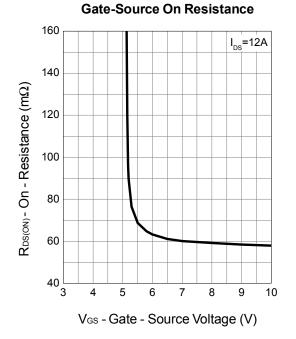


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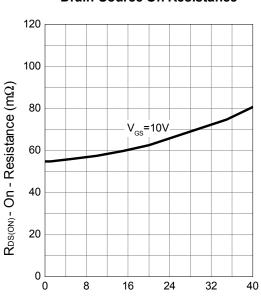
## **Typical Characteristics**



VDS-Drain - Source Voltage (V)



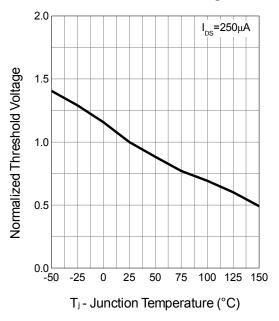
## **Output Characteristics**



**Drain-Source On Resistance** 

ID-Drain Current (A)

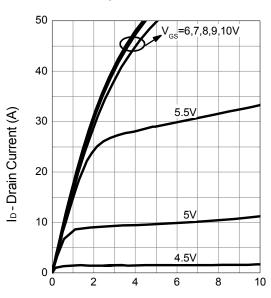
#### **Gate Threshold Voltage**



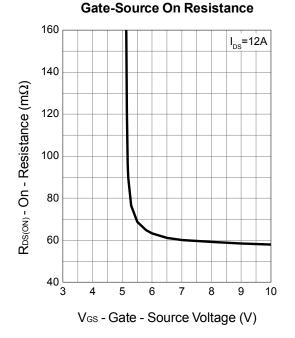


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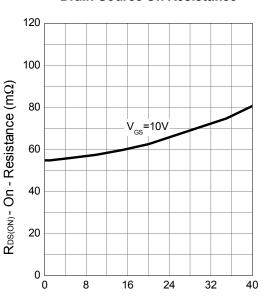
## **Typical Characteristics**



#### V<sub>DS</sub>-Drain - Source Voltage (V)



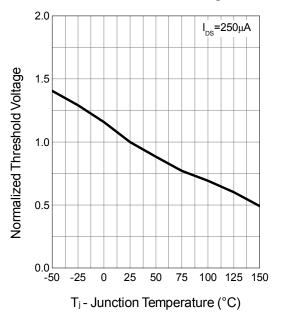
## **Output Characteristics**



## Drain-Source On Resistance

ID-Drain Current (A)

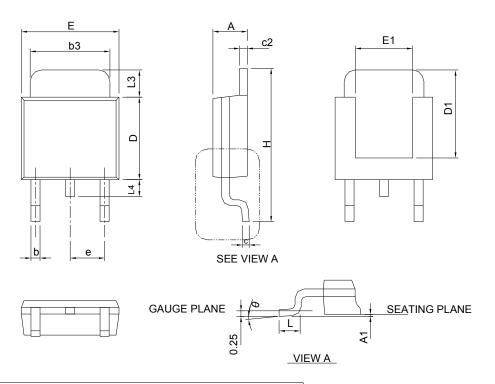
#### Gate Threshold Voltage



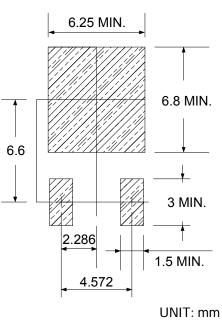


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## **TO-252 Package Information**



#### TO-252 SY MBOL MILLIMETERS INCHES MIN. MAX. MIN. MAX. Α 2.18 2.39 0.086 0.094 A1 -0.13 -0.005 0.89 0.035 b 0.50 0.020 b3 4.95 5.46 0.195 0.215 0.61 0.018 0.024 0.46 с 0.018 0.035 c2 0.46 0.89 0.210 0.245 D 5.33 6.22 4.57 0.180 D1 6.00 0.236 Е 6.35 6.73 0.250 0.265 E1 3.81 0.150 0.236 6.00 е 2.29 BSC 0.090 BSC 9.40 10.41 0.370 0.410 Н 0.90 1.78 0.070 L 0.035 L3 0.89 2.03 0.035 0.080 L4 1.02 0.040 \_ \_ 8° θ 0° 0° 8°



**RECOMMENDED LAND PATTERN** 



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